

HAT2085T

Silicon N Channel MOS FET
High Speed Power Switching

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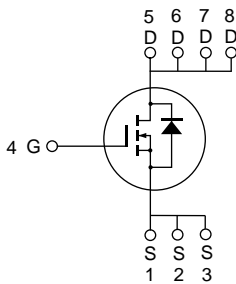
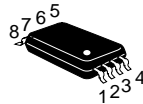
ADE-208-1028A(Z)
Target Specification 2nd. Edition
Dec. 2000

Features

- Low on-resistance
- Low drive current
- High density mounting

Outline

TSSOP-8



1, 2, 3 Sc
4
5, 6, 7, 8 Dr

Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DSS}	200	V
Gate to source voltage	V_{GSS}	±30	V
Drain current	I_D	(1.4)	A
Drain peak current	$I_{D(pulse)}$ ^{Note1}	(11.2)	A
Body-drain diode reverse drain current	I_{DR}	(1.4)	A
Channel dissipation	P_{ch} ^{Note2}	1.3	W
Channel temperature	T_{ch}	150	°C
Storage temperature	T_{stg}	−55 to +150	°C

Note: 1. $PW \leq 10\mu s$, duty cycle $\leq 1\%$

2. When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), $PW \leq 10s$

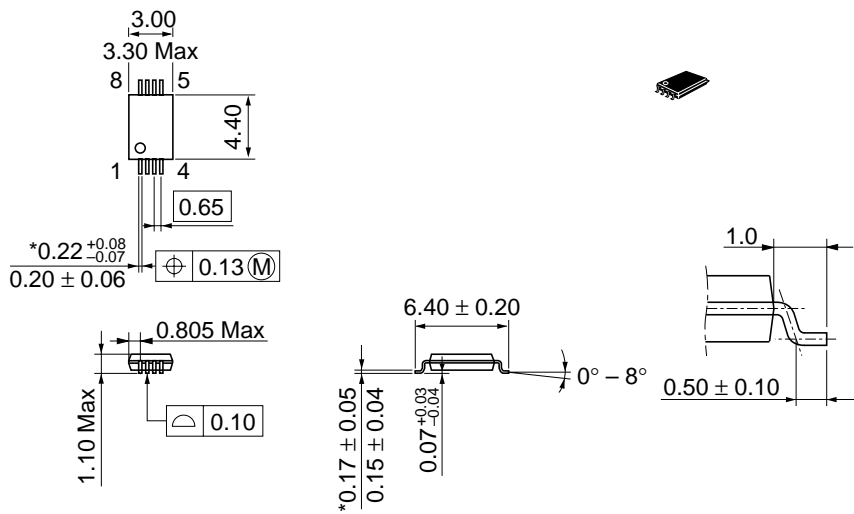
Electrical Characteristics (Ta = 25°C)

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	200	—	—	V	$I_D = 10mA$, $V_{GS} = 0$
Gate to source leak current	I_{GSS}	—	—	±0.1	μA	$V_{GS} = \pm 30V$, $V_{DS} = 0$
Zero gate voltage drain current	I_{DSS}	—	—	1	μA	$V_{DS} = 200V$, $V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	(3.0)	—	(4.5)	V	$I_D = 1mA$, $V_{DS} = 10V$
Static drain to source on state resistance	$R_{DS(on)}$	—	(0.49)	(0.64)	Ω	$I_D = 0.7A$, $V_{GS} = 10V$ ^{Note3}
Forward transfer admittance	$ y_{fs} $	(1.0)	(1.7)	—	S	$I_D = 0.7A$, $V_{DS} = 10V$ ^{Note3}
Input capacitance	C_{iss}	—	(300)	—	pF	$V_{DS} = 25V$
Output capacitance	C_{oss}	—	(43)	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	C_{rss}	—	(12)	—	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$	—	(19)	—	ns	$V_{DD} \cong 100V$, $I_D = 0.7A$
Rise time	t_r	—	(11)	—	ns	$V_{GS} = 10V$
Turn-off delay time	$t_{d(off)}$	—	(51)	—	ns	$R_L = 143\Omega$
Fall time	t_f	—	(17)	—	ns	$R_g = 10\Omega$
Total gate charge	Q_g	—	(10)	—	nC	$V_{DD} = 160V$
Gate to source charge	Q_{gs}	—	(2)	—	nC	$V_{GS} = 10V$
Gate to drain charge	Q_{gd}	—	(5)	—	nC	$I_D = 1.4A$
Body-drain diode forward voltage	V_{DF}	—	(0.8)	(1.2)	V	$I_F = 1.4A$, $V_{GS} = 0$ ^{Note3}
Body-drain diode reverse recovery time	t_{rr}	—	(60)	—	ns	$I_F = 1.4A$, $V_{GS} = 0$ $diF/dt = 100A/\mu s$

Note: 3. Pulse test

Package Dimensions

As of January, 2001
Unit: mm



*Dimension including the plating thickness
Base material dimension

Hitachi Code	TTP-8D
JEDEC	—
EIAJ	—
Mass (reference value)	—

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